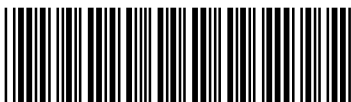


**Search Notes**

Application/Control No.

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Examiner

Trinh T. Nguyen

Applicant(s)/Patent under  
Reexamination

HOLMERTZ ET AL.

Art Unit

3644

**SEARCHED**

Class	Subclass	Date	Examiner
updated	searches	5/5/2008	TTN
as on	search		
note	11/2/07		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR